



## **SPECIFICATION**

• Supplier : Samsung electro-mechanics • Samsung P/N : CL31B225KAHNNNE

• Product : Multi-layer Ceramic Capacitor • Description : CAP, 2.2 µF, 25V, ±10%, X7R, 1206

## A. Samsung Part Number

<u>CL</u> <u>31</u> <u>B</u> <u>225</u> <u>K</u> <u>A</u> <u>H</u> <u>N</u> <u>N</u> <u>W</u> <u>E</u> ① ② ③ ④ ⑤ ⑥ ⑦ ⑧ ⑨ ⑩ ⑪

1	Series	Samsung Multi-layer Ceramic Capacitor								
2	Size	1206 (inch c	ode) L	.: 3.2	± 0.2	mm	W:	1.6	± 0.2	mm
3	Dielectric	X7R		8	Inner el	lectrode		Ni		
4	Capacitance	<b>2.2</b> μF			Termina	ation		Cu		
(5)	Capacitance	±10 %			<b>Plating</b>			Sn 10	0%	(Pb Free)
	tolerance			9	Produc	t		Norm	al	
6	Rated Voltage	25 V		10	Special			Produ	ict for N	letwork application
7	Thickness	1.6 ± 0.2	mm	11)	Packag	ing		Embo	ssed T	ype, 7" reel

## **B. Samsung Reliability Test and Judgement condition**

	Performance	Test condition					
Capacitance	Within specified tolerance	1kHz±10% 1.0±0.2Vrms					
Tan δ (DF)	0.035 max.						
Insulation	10,000Mohm or 500Mohm⋅ <i>μ</i> F	Rated Voltage 60~120 sec.					
Resistance	Whichever is Smaller						
Appearance	No abnormal exterior appearance	Microscope (×10)					
Withstanding	No dielectric breakdown or	250% of the rated voltage					
Voltage	mechanical breakdown						
Temperature	X7R						
Characteristics	(From -55℃ to 125℃, Capacitance change should be within ±15%)						
Adhesive Strength	No peeling shall be occur on the	500g·F, for 10±1 sec.					
of Termination	terminal electrode						
Bending Strength	Capacitance change : within ±12.5%	Bending to the limit (1mm)					
		with 1.0mm/sec.					
Solderability	More than 75% of terminal surface	SnAg3.0Cu0.5 solder					
	is to be soldered newly	245±5℃, 3±0.3sec.					
		(preheating : 80~120 ℃ for 10~30sec.)					
Resistance to	Capacitance change: within ±7.5%	Solder pot : 270±5℃, 10±1sec.					
Soldering heat	Tan δ, IR : initial spec.						

	Performance	Test condition					
Vibration Test	Capacitance change : within ±5%	Amplitude : 1.5mm					
	Tan δ, IR : initial spec.	From 10Hz to 55Hz (return : 1min.)					
		2hours × 3 direction (x, y, z)					
Moisture	Capacitance change : within ±12.5%	With rated voltage					
Resistance	Tan δ : 0.05 max	40±2℃, 90~95%RH, 500+12/-0hrs					
	IR : 500Mohm or 25Mohm ⋅ μF						
	Whichever is Smaller						
High Temperature	Capacitance change : within ±12.5%	With 200% of the rated voltage					
Resistance	Tan δ : 0.05 max	Max. operating temperature					
	IR : 1000Mohm or 50Mohm $\cdot  \mu$ F						
	Whichever is Smaller	1000+48/-0hrs					
Temperature	Capacitance change : within ±7.5%	1 cycle condition					
Cycling	Tan δ, IR : initial spec.	Min. operating temperature $ ightarrow$ 25 $^{\circ}$ C					
		$ ightarrow$ Max. operating temperature $ ightarrow$ 25 $^{\circ}\!$					
		5 cycle test					

## C. Recommended Soldering method :

Reflow ( Reflow Peak Temperature : 260+0/-5  $^{\circ}$ C , 10sec. Max )

<sup>\*</sup> For the more detail Specification, Please refer to the Samsung MLCC catalogue.